

Fabrication of a High Heat Dissipating Double-Sided Printed Circuit Board

by Hu Wencheng,* Yang Chuanren, Qiu Yan & Zhu Lin

The technique for fabricating high heat dissipating double-sided printed circuit boards (PCB) was studied and we have developed an improved process to prepare them. Films of aluminum oxide are grown on circuit elements by anodization. Polyimide mixed with fine aluminum nitride powder is used as a binder to improve the thermal conductivity. The aluminum-base PCB is prepared after lamination, etching and subsequent steps. Thermal resistance testing of the PCB showed a value of less than 0.125 K°/W·m².

Printed circuit boards (PCB) are used in electronic devices and components over a wide range of applications.¹ At present, continuing trends in PCB technology are toward higher circuit density, higher accuracy and miniaturization.² Smaller spaces and higher-powered integrated circuits produce more energy that must be dissipated, which influences the thermal characteristics of the electronic package,³ as well as its design, in order to avoid damage to the components. The traditional method is to use hardware, such as an electric fan, to lower the temperature. This in itself requires a large amount of space, which is not in accord with the trends of PCB development.

In order to meet such high heat dissipation requirements, there are available ceramic PCB bases which exhibit high thermal conductance and metal bases, such as aluminum substrates.⁴ The advantages of the metal bases

are ease of fabrication, no restriction on size and relatively low cost. The fragility of ceramic baseboards leads to the opposite: relatively high cost, difficulty in fabrication and restrictions on practical size. Hence, the metal-based PCBs are the primary avenue of research into high heat dissipating PCBs, which can be applied in IGBT modules, electric vehicles, switch power modules and high-power devices.

At present, the metals suitable for metal-based PCBs are aluminum, copper and Invar.⁵ Aluminum exhibits low density, high heat conductivity, low cost and excellent mechanical processing characteristics. Hence, it is commonly used in metal-based PCBs. However, its expansion coefficient is relatively large. The expansion coefficient of copper is lower than that of aluminum, and its heat conductivity is excellent, but its cost is higher and copper is heavier, increasing the weight of the PCB. The expansion coefficient of Invar is very low, but its heat conduction coefficient is very small. Hence, Invar is usually used in PCBs where thermal expansion matching is the key factor. In this work, we used aluminum as the metal base.

Heat dissipation in aluminum based PCBs

Aluminum substrates are primarily used in power circuits, where the heat produced by the circuit must be fully considered in the design of the circuit. Generally, the circuit is designed according to IPC-2221 and 2222.⁶ For a given circuit width, where the temperature rise is below 20°C (68°F), it can be said that such a PCB has no thermal problems. Such a metal-based PCB is shown in Fig. 1.

The primary direction of thermal flow produced by the components in a PCB is:

Components → Circuit copper layer → Binder layer → Alumina layer → Aluminum layer → Air

Nuts & Bolts: What This Paper Means to You

As the various elements on printed circuit boards get smaller and smaller, and more of them are densely packed on the board, more heat is generated which must be carried away. The venerable electric fan just cannot do it alone anymore. In this work with aluminum bases, a polyimide mixed with aluminum nitride powder is added to improve the thermal conductivity of the circuitry itself.

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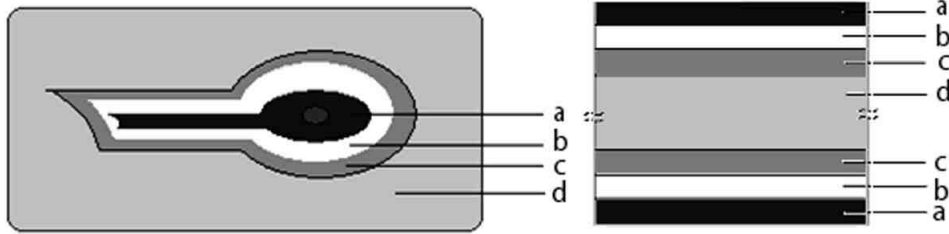


Figure 1—Portion of a high heat-dissipating printed circuit board: (a) circuit, (b) binder layer, (c) alumina layer and (d) aluminum base.

It is obvious that all steps involve heat conduction, except for the last step, which involves convective heat transfer. Conductive heat transfer can be expressed as:

$$Q = \frac{\Delta t}{\sum(\delta_i / \lambda_i A_i)}; R_i = \delta_i / \lambda_i A_i \quad (1)$$

where Δt = temperature difference,

δ_i = thickness of the thermal conduction layer,

λ_i = thermal conductivity,

A_i = area of the thermal conduction layer and

R = thermal resistance.

The equation of the convective heat transfer is:

$$Q = \alpha A \Delta t = \frac{\Delta t}{\frac{1}{\alpha A}}; R = \frac{1}{\alpha A} \quad (2)$$

where α = heat transfer coefficient.

Preparation process

The preparation sequence for the aluminum substrate is shown in the flow diagram of Fig. 2. The goal of the first exposure and development of the photosensitive emulsion is (1) to anodize the areas of the circuit and the hole walls of the aluminum base and (2) prevent an anodized layer on the heat dissipating area from forming which would otherwise reduce the thermal resistance. The thickness of the anodized alumina layer should be limited to 50 μm (0.002 in.). We used polyimide mixed with fine aluminum nitride powder as the screen-printing binder. After the screen-printing process, the binder was coated on the circuit and hole wall areas. Raising the temperature to 190°C (374°F), the copper foil, containing pre-drilled holes, was laminated onto the aluminum base. Because of the low thermal conductivity of air, a vacuum was applied during

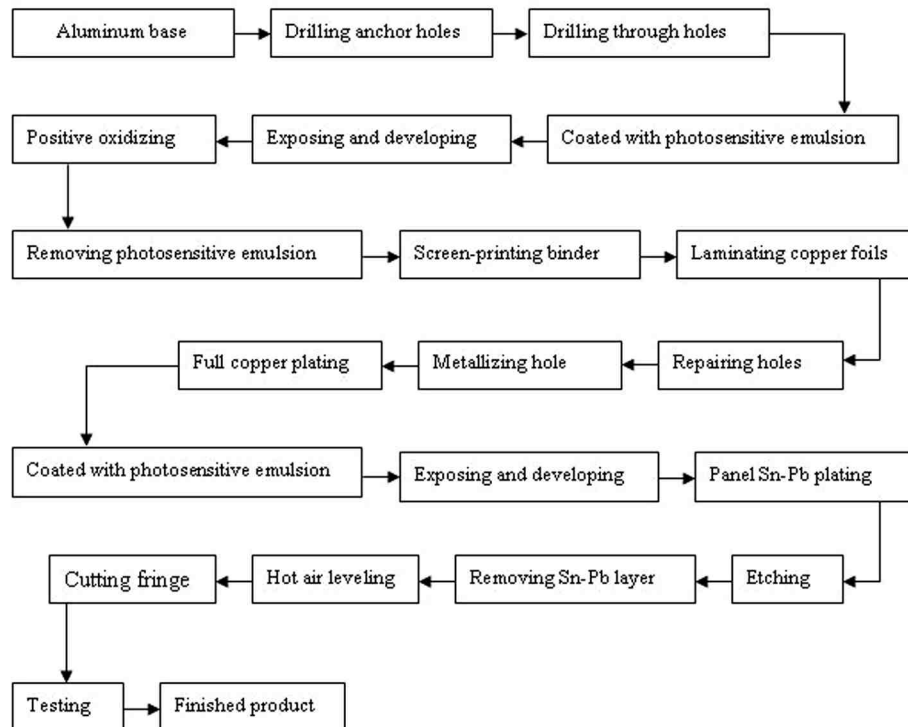


Figure 2—Technological process of preparing aluminum substrate printed circuit boards.

the lamination process in order to prevent air from remaining in the binder. The experimental pressure used here was 80 kPa (11.6 lb/in²).

The hole repair process is intended to assure that (1) all holes in the aluminum base plate correspond to those on the copper foil and (2) the surface of alumina layer on the hole walls remain smooth. The hole metallization process was traditional electroless copper plating. The electroless copper layer thickness was about 0.5 μm (19.7 $\mu\text{-in.}$). The copper plating process increased the thickness of the copper layer on the hole walls to about 5 μm (197 $\mu\text{-in.}$). The second exposure and development of the photosensitive emulsion was done in order to electroplate the Sn-Pb layer on the circuit. The etching process was the traditional alkaline copper chloride process.

Thermal conductivity of polyimide mixed with fine aluminum nitride powder

The thermal conductivity values of bonding sheets typically used in the PCB industry are too low. For example, the thermal conductivity of FR-4 b-stage resin is about 0.25 W/m²·K. Hence, they cannot be directly applied to heat dissipating PCBs. Aluminum nitride exhibits high thermal conductivity and insulating resistance. Hence, we used polyimide mixed with fine aluminum nitride powder as a binder to improve its thermal conductivity.

The theoretical thermal conductivity of an aluminum nitride single crystal is estimated to be 320 W/m²·K.⁷ In the present study, we determined that aluminum nitride ceramic material with a thermal conductivity as high as 260 W/m²·K could be prepared by hot-press sintering. Fine aluminum nitride powder was prepared using a self-propagating synthetic sintering method. The powder size was about 1 to 3 μm (39 to 118 $\mu\text{-in.}$), as shown in Fig. 3. We studied the effect of the concentration of aluminum nitride powder in the binder on the thermal conductivity, and the result is shown in Fig. 4. The thermal conductivity increased with increasing aluminum nitride content. Above an aluminum nitride content of 70%, the thermal conductivity still increased rapidly, but the strength between the binder and base rapidly weakened. Hence, the optimum content of aluminum nitride in the binder was 60 to 70%, corresponding to a thermal conductivity of 5.57 to 15.16 W/m²·K. Further increases in the thermal conductivity of the binder were unnecessary, because the thermal conductivity of the anodized layer was the main thermal resistance when the thermal conductivity of the binder reached a certain value.

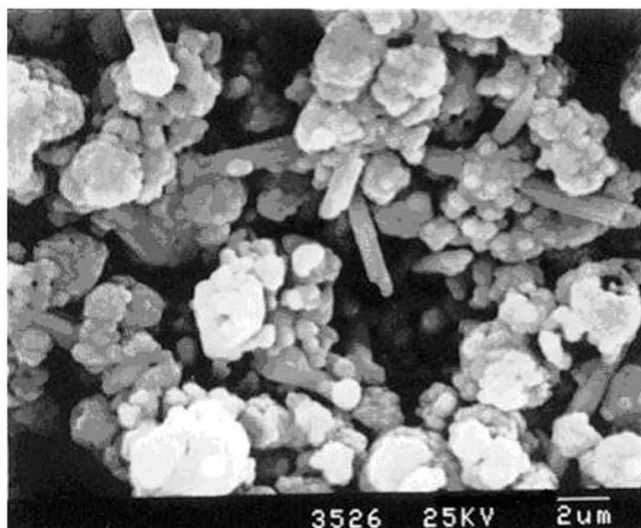


Figure 3—SEM image of fine aluminum nitride powder.

The performance of high heat dissipating double-sided PCBs

The high heat dissipating double-sided PCB was tested, and its characteristics are shown in Table 1. Compared with a conventional PCB, the high heat dissipating double-sided PCB performs favorably well, and its thermal resistance per unit area is less than 0.125 K²/W·m².

Summary

In conclusion, we have described a process for the preparation of high heat dissipating double-sided PCBs with improved thermal conductivity, using a polyimide mixed with fine aluminum nitride powder as a binder, prepared by a self-propagating synthetic sintering method. We also studied the effect of the ratio of aluminum nitride powder in the binder on the thermal conductivity. The high heat dissipating double-sided PCB was tested according to standard specifications, and the results showed that its thermal resistance per unit area was less than 0.125 K²/W·m². Other characteristics were comparable to those of conventional PCBs.

Table 1
Characteristics of the high heat dissipating double-sided printed circuit board

Performance	Experimental Value
Bonding strength of Cu foil	>1.8 kgf/cm
Thermal shock test (288°C; 550°F)	>30 sec
Dielectric breakdown strength	>30 kV
Volume resistance of resin layer	>10 ¹² $\Omega\cdot\text{cm}$
Thermal resistance per unit area	<0.125 K ² /W·m ²
Thermal cycle (Boil & freeze water cycle)	10 cycles (no change)

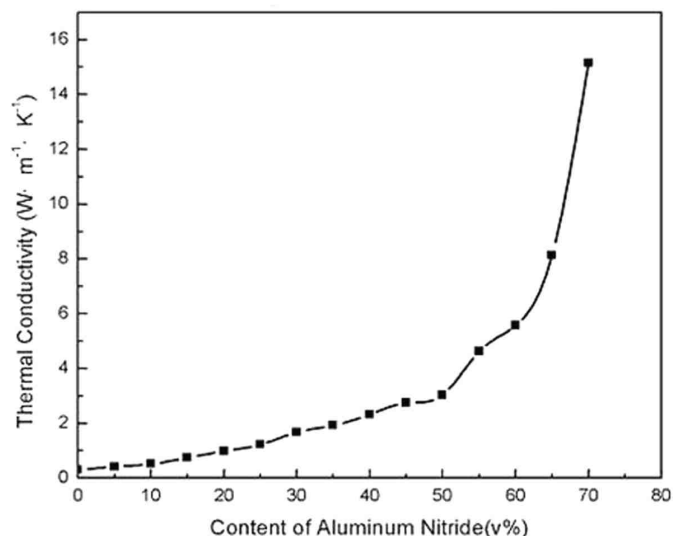


Figure 4—Relation between the thermal conductivity and the amount of fine aluminum nitride powder in binder.

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